

FDP13N40 / FDB13N40

13A, 400V, 0.37 Ohm, N-Channel SMPS Power MOSFET

Applications

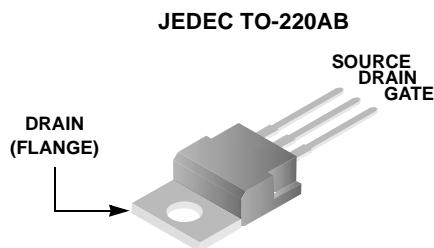
Switch Mode Power Supplies(SMPS), such as

- PFC Boost
- Two-Switch Forward Converter
- Single Switch Forward Converter
- Flyback Converter
- Buck Converter
- High Speed Switching

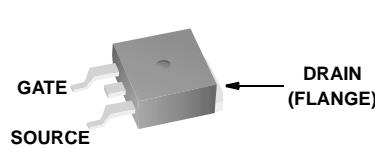
Features

- Low Gate Charge Q_g results in Simple Drive Requirement
- Improved Gate, Avalanche and High Reapplied dv/dt Ruggedness
- Reduced $r_{DS(ON)}$
- Reduced Miller Capacitance and Low Input Capacitance
- Improved Switching Speed with Low EMI
- 175°C Rated Junction Temperature

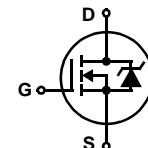
Package



JEDEC TO-220AB



Symbol



Absolute Maximum Ratings $T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Ratings	Units
V_{DSS}	Drain to Source Voltage	400	V
V_{GS}	Gate to Source Voltage	± 30	V
I_D	Drain Current Continuous ($T_C = 25^\circ\text{C}$, $V_{GS} = 10\text{V}$)	13	A
	Continuous ($T_C = 100^\circ\text{C}$, $V_{GS} = 10\text{V}$)	9.2	A
	Pulsed (Note 1)	52	A
P_D	Power dissipation Derate above 25°C	250	W
		1.67	W/ $^\circ\text{C}$
T_J , T_{STG}	Operating and Storage Temperature	-55 to 175	$^\circ\text{C}$
	Soldering Temperature for 10 seconds	300 (1.6mm from case)	$^\circ\text{C}$
	Mounting Torque, 8-32 or M3 Screw	10ibf*in (1.1N*m)	

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance Junction to Case	0.6	$^\circ\text{C/W}$
$R_{\theta CS}$	Thermal Resistance Case to Sink, Flat, Greased Surface	0.50 TYP	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance Junction to Ambient	62	$^\circ\text{C/W}$

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDP13N40	FDP13N40	TO-220AB	Tube	-	50
FDB13N40	FDB13N40	TO-263AB	330mm	24mm	800

Electrical Characteristics $T_C = 25^\circ\text{C}$ (unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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Statics

B_{VDS}	Drain to Source Breakdown Voltage	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$	400	-	-	V
$\Delta B_{VDS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	$V/\text{ }^\circ\text{C Reference to } 25^\circ\text{C}$ $I_D = 1\text{mA}$	-	0.48	-	
$r_{DS(ON)}$	Drain to Source On-Resistance	$V_{GS} = 10\text{V}, I_D = 6.5\text{A}$	-	0.35	0.37	Ω
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	2.0	3.2	4.0	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 400\text{V}$ $V_{GS} = 0\text{V}$	$T_C = 25^\circ\text{C}$ $T_C = 150^\circ\text{C}$	-	25	μA
I_{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20\text{V}$	-	-	± 100	nA

Dynamics

g_{fs}	Forward Transconductance	$V_{DS} = 50\text{V}, I_D = 6.5\text{A}$	7	-	-	S
$Q_{g(TOT)}$	Total Gate Charge at 10V	$V_{GS} = 10\text{V}$	-	18.3	22	nC
Q_{gs}	Gate to Source Gate Charge	$V_{DS} = 320\text{V}$	-	5	6	nC
Q_{qd}	Gate to Drain "Miller" Charge	$I_D = 13\text{A}$	-	5.8	7	nC
$t_{d(ON)}$	Turn-On Delay Time	$V_{DD} = 200\text{V}$	-	7.5	-	ns
t_r	Rise Time	$I_D = 13\text{A}$	-	25.5	-	ns
$t_{d(OFF)}$	Turn-Off Delay Time	$R_G = 10\Omega$	-	33.5	-	ns
t_f	Fall Time	$R_D = 15.4\Omega$	-	26.4	-	ns
C_{ISS}	Input Capacitance	$V_{DS} = 25\text{V}, V_{GS} = 0\text{V}$	-	1060	-	pF
C_{OSS}	Output Capacitance	$f = 1\text{MHz}$	-	143	-	pF
C_{RSS}	Reverse Transfer Capacitance	-	-	6	-	pF

Avalanche Characteristics

E_{AS}	Single Pulse Avalanche Energy (Note 2)		591	-	-	mJ
I_{AR}	Avalanche Current		-	-	13	A

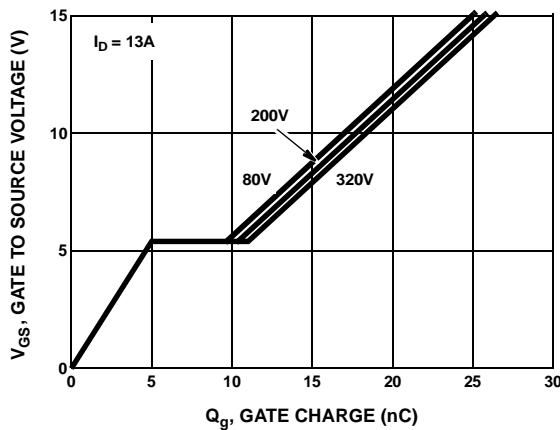
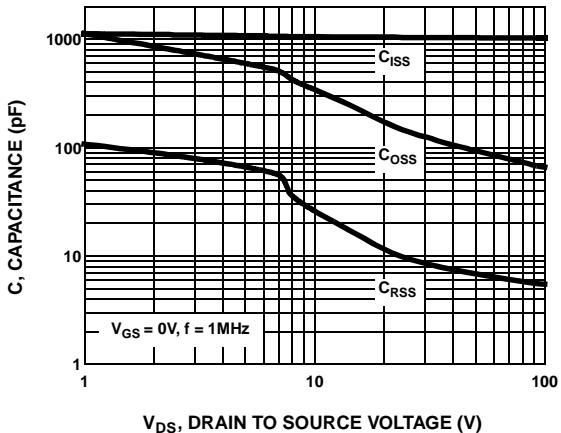
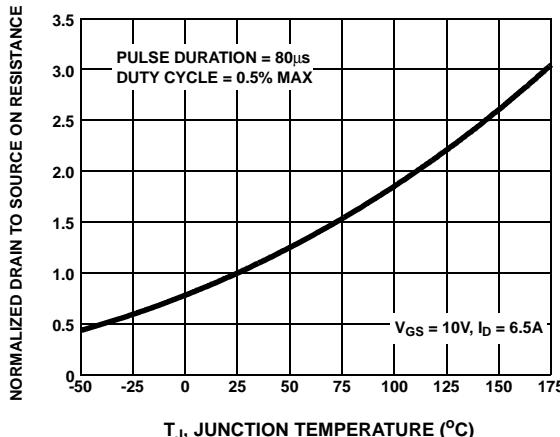
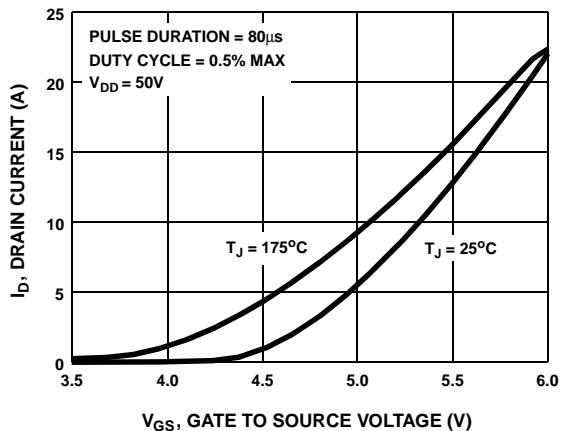
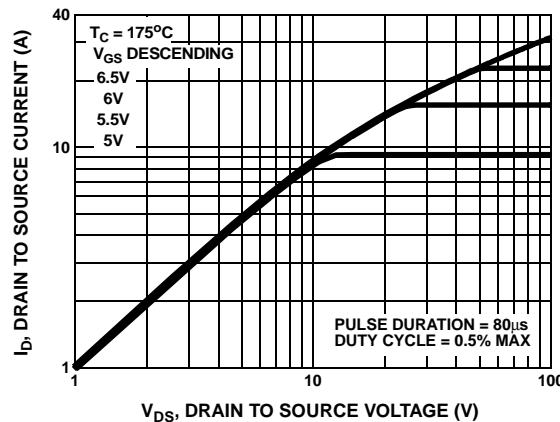
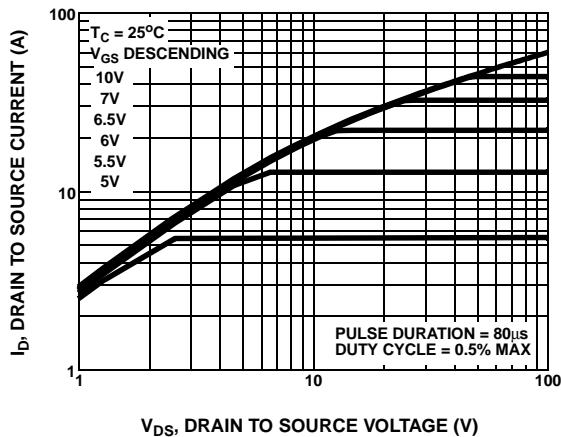
Drain-Source Diode Characteristics

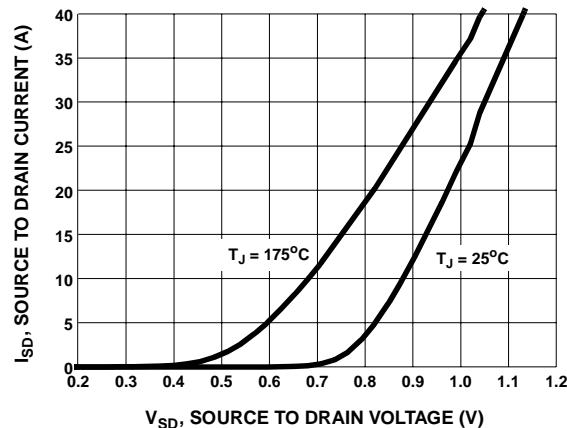
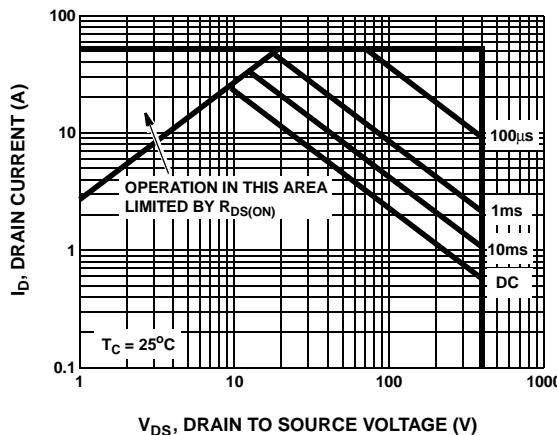
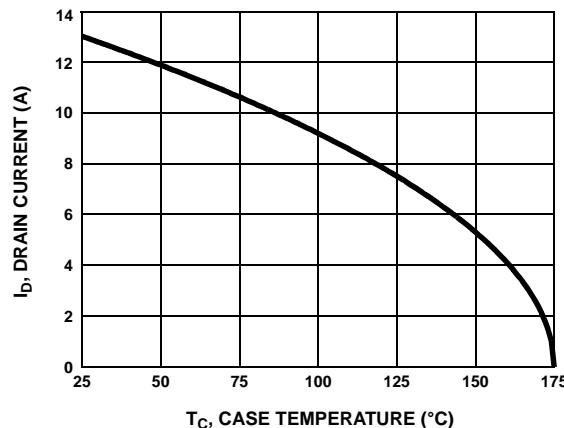
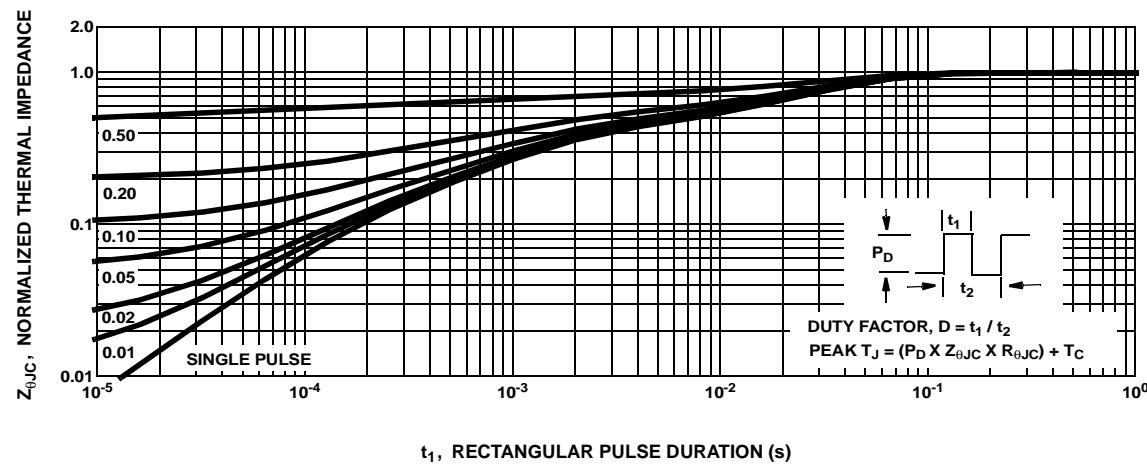
I_S	Continuous Source Current (Body Diode)	MOSFET symbol showing the integral reverse p-n junction diode.	-	-	13	A
I_{SM}	Pulsed Source Current (Note 1) (Body Diode)	-	-	-	52	A
V_{SD}	Source to Drain Diode Voltage	$I_{SD} = 13\text{A}$	-	0.9	1.2	V
t_{rr}	Reverse Recovery Time	$I_{SD} = 13\text{A}, dI_{SD}/dt = 100\text{A}/\mu\text{s}$	-	280	364	ns
Q_{RR}	Reverse Recovered Charge	$I_{SD} = 13\text{A}, dI_{SD}/dt = 100\text{A}/\mu\text{s}$	-	2.6	3.4	μC

Notes:

- 1: Repetitive rating; pulse width limited by maximum junction temperature
2: Starting $T_J = 25^\circ\text{C}$, $L = 7\text{mH}$, $I_{AS} = 13\text{A}$

Typical Characteristic



Typical Characteristic (Continued)**Figure 7. Source to Drain Diode Forward Voltage****Figure 8. Maximum Safe Operating Area****Figure 9. Maximum Drain Current vs Case Temperature****Figure 10. Normalized Maximum Transient Thermal Impedance**

Test Circuits and Waveforms

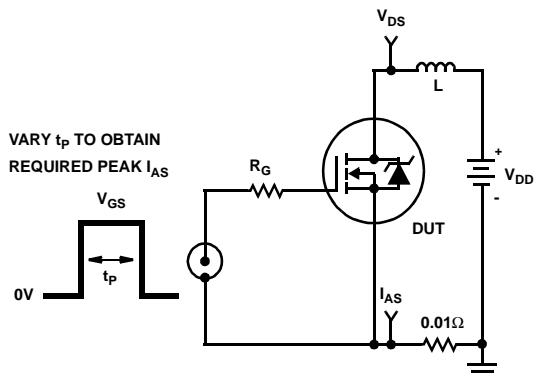


Figure 11. Unclamped Energy Test Circuit

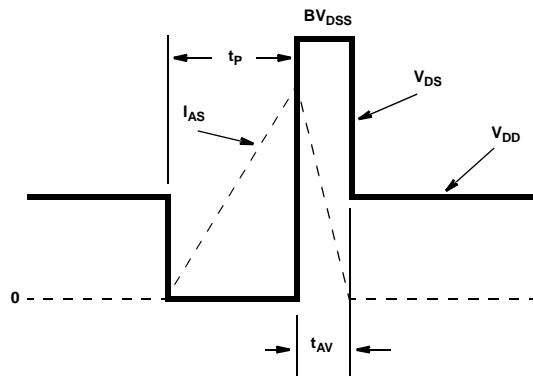


Figure 12. Unclamped Energy Waveforms

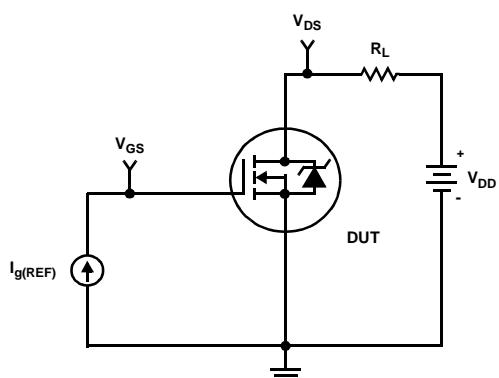


Figure 13. Gate Charge Test Circuit

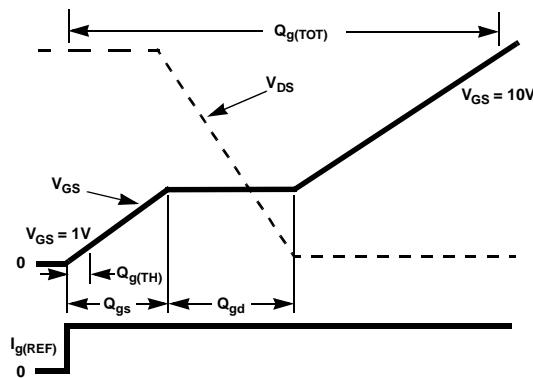


Figure 14. Gate Charge Waveforms

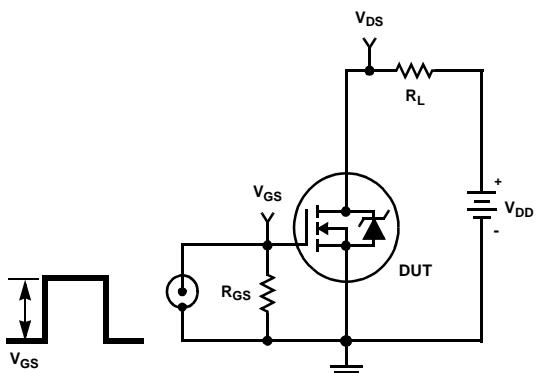


Figure 15. Switching Time Test Circuit

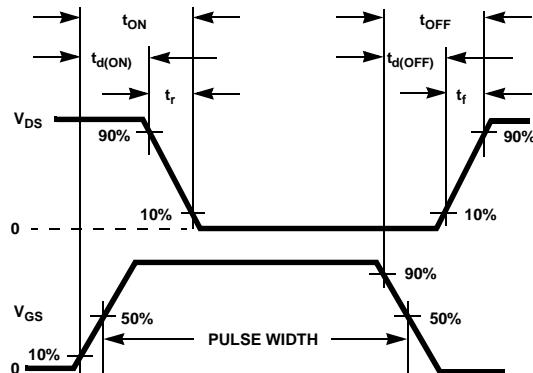


Figure 16. Switching Time Waveform

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